

**Search Notes****Application/Control No.**

10/644,217

**Examiner**

Sikyin Ip

**Applicant(s)/Patent under Reexamination**

YAMAGISHI ET AL.

**Art Unit**

1742

**SEARCHED**

Class	Subclass	Date	Examiner
148	433		
420	472		
	473		
	474		
	476		
	477		
	481	3/15/2006	SI

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN	3/15/2006	SI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner